

Notice of References Cited	Application/Control No. 09/869,582	Applicant(s)/Patent Under Reexamination YANOFSKY, MARTIN F.	
	Examiner Stuart F. Baum	Art Unit 1638	Page 1 of 2

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	Hao, et al (1998, The J. of Biological Chemistry 273 (41): 26857-26861)
	W	Busch et al (1999, Science 285:585-587)
	X	Lohmann et al (2001, Cell 105 :793-803)

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	Examiner Stuart F. Baum	Art Unit 1638	Page 2 of 2

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